

LIST OF ART CITED BY APPLICANT
(PTO-1449)

ATTY. DOCKET NO.
P-0776

APPLN. SERIAL NO.
10/576,580

APPLICANT(S)

Yoon-Seob EOM et al.

FILING DATE
April 20, 2006

GROUP
3744

U.S. PATENT DOCUMENTS

| EXAMINER'S INITIALS | *PATENT NO. | *ISSUE DATE | *INVENTOR NAME | CLASS | SUBCLASS | FILING DATE |
|---------------------|-------------|-------------|----------------|-------|----------|-------------|
| | 3,811,293 | 05/1974 | Flynn | | | |
| | 6,272,878 | 08/2001 | Chang | | | |
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U.S. PATENT APPLICATION PUBLICATIONS

| | *PATENT APPLN. PUB. NO. | *PUB. DATE | *APPLICANT | CLASS | SUBCLASS |
|--|-------------------------|------------|-------------|-------|----------|
| | 2001/0035021 | 11/2001 | Kang et al. | | |
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U.S. PATENT APPLICATIONS

| | *APPLN. NO. | *FILING DATE | *INVENTOR | CLASS | SUBCLASS |
|--|-------------|--------------|-----------|-------|----------|
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FOREIGN PATENT DOCUMENTS

| EXAMINER'S INITIALS | PATENT NO. | DATE | COUNTRY | CLASS | SUBCLASS | Translation | |
|---------------------|-------------|---------|---|-------|----------|-------------|----|
| | | | | | | Yes | No |
| | JP59-074439 | 04/1984 | Japan (English Abstract & full Japanese text) | | | X | |
| | JP10-068535 | 03/1998 | Japan (English Abstract & full Japanese text) | | | X | |
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OTHER ART (Including Author, Title, Date, Pertinent Pages, Publisher, Place of Publication, Etc.)

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EXAMINER

DATE CONSIDERED

EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; draw line through citation if not in conformance and not considered. Include copy of this form with next communication to Applicant.
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